

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/025,390	FRENCH ET AL.
	<b>Examiner</b> Isaac M. Woo	<b>Art Unit</b> 2166

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB&USPAT text search - See history search printout		12/14/2005	IW